MITSUMI

Miniature 6-axis force torque sensor

MMS101 Datasheet

DESCRIPTION



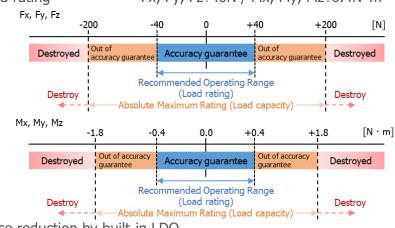
This is a 6-axis force torque sensor which has 3-axis force and 3-axis moment. It has a hybrid structure of a MEMS chip and a metal structure, realizing 6-axis detection. This product has AFE ICs built in its module and produces digital output (SPI). Correction coefficients used for matrix operation (other axis interference components are removed) are stored in memories inside the AFE ICs. Since they can be read out immediately before the measurement start, users do not have to control the sensor and the correction coefficients. Additionally, the LDO built in the module reduces noises. This product is extremely small and light, suitable for fingertips of robot hands.

*Precautions

- Before installing and using this product, please carefully read <u>"PRECAUTIONS FOR SENSOR</u> <u>INSTALLATION</u>" and <u>"PRECAUTIONS FOR SENSOR HANDLE</u>" in this document. Otherwise, incorrect installation may cause damage to this product. Pay particular attention to damage to the inner components due to incorrect length of the mounting screws and disconnection due to handling of FPC.
- This product is intended to be used with the sensor attachment mounted on a screw. Please read the "Sensor Attachment" carefully and design and prepare the sensor attachment by yourself.
- Because this product is a metal structure and small, it is sensitive to changes in environmental temperature and heat, which may affect the output. If necessary, please consider changing the shape and size of the sensor attachment and using the temperature sensor value update function for offset temperature correction to make it less susceptible to temperature changes and heat. For details of the temperature sensor value update function for offset temperature correction, refer to <u>"Update temperature sensor value for offset temperature correction"</u>.
- Immediately after measuring starts, the built-in AFE generates heat and drifts. Therefore, it is recommended to acquire data after drift stabilization. For details, refer to the <u>"Measurement start instruction"</u>.
- This product is equipped with a sensor attachment for inspection at the time of shipment inspection to adjust the offset. Therefore, the offset is output when the sensor attachment is not attached. Also, offset output may occur even when the sensor attachment is mounted in a no-load condition. Use an external MCU to cancel the offset output. For details, check "<u>Offset cancel</u>".

FEATURES

- · Very small: Φ 9.6(W) × 9.0(H) mm
- Light weight: 3 g
 - High load capacityFx, Fy, Fz: 200N / Mx, My, Mz: 1.8N•mLoad ratingFx, Fy, Fz: 40N / Mx, My, Mz: 0.4N•m



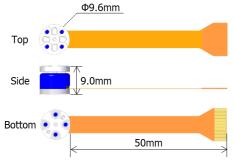


Fig. 1 Product appearance

- Noise reduction by built-in LDO Fx, Fy:0.04N RMS / Fz:0.06N RMS
 - Mx, My:0.0004N•m RMS / Mz:0.0008N•m RMS
- · Digital output of 6-axis data by built-in sequencer (SPI)
- RoHS compliant
- Halogen-contained

MODEL NUMBER

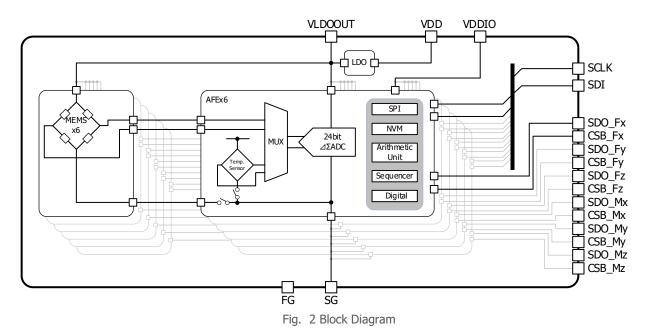
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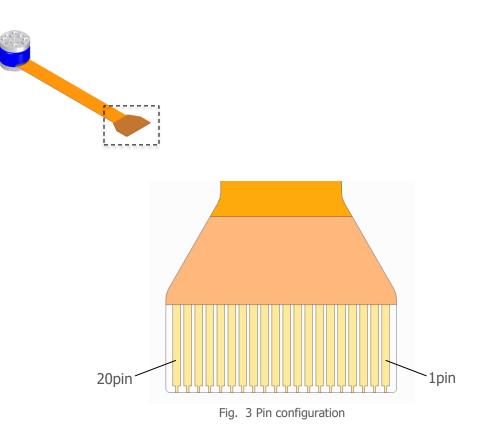
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BLOCK DIAGRAM

This product has six AFEs corresponding to each axis. Please switch CSB pin voltage level to access each AFE for operation.



PIN CONFIGURATION



*The terminal are located on the back of the FPC. The above finger is a perspective view. Table 1 Pin table

No.	Pin Name	Туре	Function
1	FG	-	Frame ground
2	FG	-	Frame ground
3	CSB_Fz	Ι	AFE3(Fz) Chip select for SPI communication (negative logic)
4	SDO_Fz	0	AFE3(Fz) Serial Data Output for SPI communication
5	CSB_Mz	Ι	AFE6(Mz) Chip select for SPI communication (negative logic)
6	SDO_Mz	0	AFE6(Mz) Serial Data Output for SPI communication
7	CSB_Mx	Ι	AFE4(Mx) Chip select for SPI communication (negative logic)
8	CSB_My	Ι	AFE5(My) Chip select for SPI communication (negative logic)
9	VDDIO	Ι	Digital I/O power supply
10	VLDOOUT	0	Built-in LDO output * Not-in-use during normal operation. However, it is recommended to connect a capacitor (10uF) near the sensor connection cable connector on your circuit board for noise reduction.
11	VDD	Ι	Analog power supply
12	SG	-	Signal ground
13	CSB_Fx	Ι	AFE1(Fx) Serial Data Output for SPI communication
14	SCLK	Ι	Serial clock for SPI communication
15	SDO_Fy	0	AFE2(Fy) Serial Data Output for SPI communication
16	SDI	Ι	Serial Data Input for SPI communication
17	SDO_My	0	AFE5(My) Serial Data Output for SPI communication
18	SDO_Fx	0	AFE1(Fx) Serial Data Output for SPI communication
19	SDO_Mx	0	AFE4(Mx) Serial Data Output for SPI communication
20	CSB_Fy	Ι	AFE2(Fy) Chip select for SPI communication (negative logic)

ABSOLUTE MAXIMUM RATINGS

(unless otherwise specified, $Ta = 25^{\circ}C$)

Item	Symbol	Min.	Max.	Unit
Load capacity	Fmax	-200	200	Ν
Load capacity	M _{MAX}	-1.8	1.8	N∙m
Storage temperature range	T _{STG}	-10	+60	°C
Analog supply voltage	VDD _{MAX}	-0.3	+15	V
Digital I/O voltage	VDDIO _{MAX}	-0.3	+4.0	V

RECOMMENDED OPERATING CONDITIONS

(unless otherwise specified, T	unless otherwise specified, Ta = 25°C)										
Item	Symbol	Max.	Unit								
Load rating	Forr	-40	40	Ν							
Load Facing	Mopr	-0.4	0.4	N∙m							
Operating temperature range	T _{OPR}	+5	+45	°C							
Analog supply voltage	VDDopr	+3.8	+14	V							
Digital I/O voltage	VDDIOOPR	+1.14	+3.6	V							

Power-on sequence

There is no specification for the power-on sequence of both VDD and VDDIO supplies. When the power is turned on, access the device at least 10msec after both VDD and VDDIO supplies have reached 90% of the applied voltage.

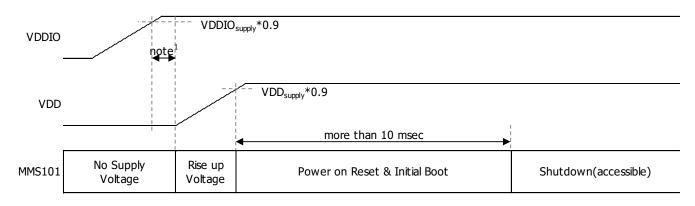


Fig. 4 Power-on sequence

note¹: No time is specified from starting VDDIO to input VDD. There is no problem even if the power-on sequence of both VDD and VDDIO supplies is reversed.

FORCE TORQUE SENSOR CHARACTERISTICS

(unless otherwise specified, $Ta = 25^{\circ}C$, $VDD = 3.8$ to 14 V, $VDDIO = 1.14$ to
--

1			d = 25 C, VDD = 5.0 CO	1.1710010			
Iten	n	Symbol	Condition	Min.	Тур.	Max.	Unit.
Theoretical	FxFyFz	F _{RES}	-	-	0.001	-	Ν
resolution	MxMyMz	M _{RES}	-	-	0.00001	-	N∙m
	FxFy	F _{Eresxy}	-	-	0.04	-	N RMS
Effective	Fz	F _{Eresz}	-	-	0.06	-	N RMS
resolution (note ²)	MxMy	M _{Eresxy}	-	-	0.0004	-	N∙m RMS
	Mz	M_{Eresz}	-	-	0.0008	-	N∙m RMS
Linea (note ²		F∟ M∟	FS=40N or 0.4N∙m	-1.0	-	1.0	%FS
Hyster (note		F _{Hys} M _{Hys}	FS=40N or 0.4N∙m	-1.0	-	1.0	%FS
Accura (note ²		F _{Acc} M _{Acc}	FS=40N or 0.4N∙m	-5.0	-	5.0	%FS
Conversio (note		t _{con}	-	-	781.25	-	usec
Laten (note	,	t _{lat}	Conversion time: Typ. Communication clock: 1MHz No delay in switching of AFE to access	-	-	2.0	msec

note²: The values in chart are the results of the measurement using our evaluation equipment and board. note³: With sensor attachments installed on the upper and lower of this product. note⁴: Design assurance item Definition of Force Torque Sensor Characteristics

Full Scale FS

Full-scale FS is 40N or 0.4N m from zero to the load rating for positive and negative.

- Theoretical resolution The value is equivalent to 1LSB of output data.
- Effective resolution

Standard deviation of 500-point data acquired after measurement is started with no load and the output is stabled.

Linearity

Deviation from Reference line connecting the output between no load state and +40N ($0.4N \cdot m$) applied state or -40 N ($0.4N \cdot m$) applied state.

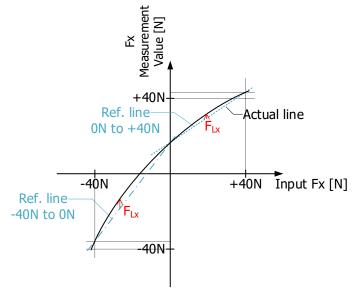
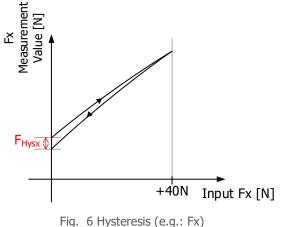


Fig. 5 Linearity (example: Fx)

Hysteresis

Change amount from the origin after having applied the load ratings (+40N (0.4N·m) or -40N (-0.4N·m)).



Accuracy

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Deviation of the applied load and output when a load is applied to the main axis while the offset output in the unloaded state is canceled. Offset output may occur even under no-load condition after the upper and lower sensor attachments are installed with screws. Cancel the offset output with an external MCU.

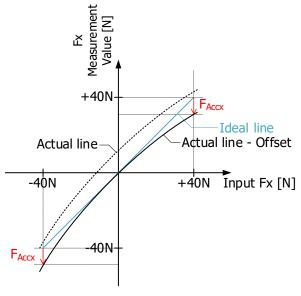


Fig. 7 Accuracy (e.g.: Fx)

- Conversion time Update interval of ADC data output from each AFE
- Latency

Delay time from the timing of output data measurement to the timing of matrix operation completion.

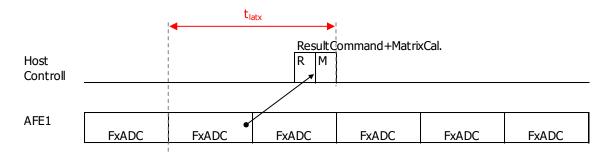


Fig. 8 Latency (e.g.: Fx)

ELECTRICAL CHARACTERISTICS

Analog Characteristics

(unless otherwise specified, $Ta = 25^{\circ}C$, VDD = 4.5 V, VDDIO = 1.2 V)

Item	Symbol	Condition	Min.	Тур.	Max.	Unit.
VDD Current consumption	IvDDact	Measure active	-	-	10	mA
VDDIO Current consumption	IVDDIOact	Measure active	-	-	20	uA

Digital I/O Characteristics

(unless otherwise specified, $Ta = 25^{\circ}C$, VDD = 3.8 to 14 V, VDDIO = 1.14 to 3.6 V)

Item	Symbol	Condition	Min.	Тур.	Max.	Unit
High level Input voltage	V_{IH}	-	$0.8 \times VDDIO$	-	VDDIO + 0.3	V
Low level Input voltage	VIL	-	-0.3	-	$0.2 \times VDDIO$	V
Output voltage	V _{OH1}	VDDIO \geq 2.0V, Iload = -3mA	VDDIO - 0.4	-	-	V
High level	V _{OH2}	VDDIO < 2.0V, Iload = -1mA	$0.8 \times VDDIO$	-	-	V
Output voltage	V _{OL1}	$\begin{array}{l} \text{VDDIO} \geqq 2.0\text{V},\\ \text{Iload} = 3\text{mA} \end{array}$	-	-	0.4	V
Low level	V _{OL2}	VDDIO < 2.0V, Iload = 1mA	-	-	$0.2 \times VDDIO$	V

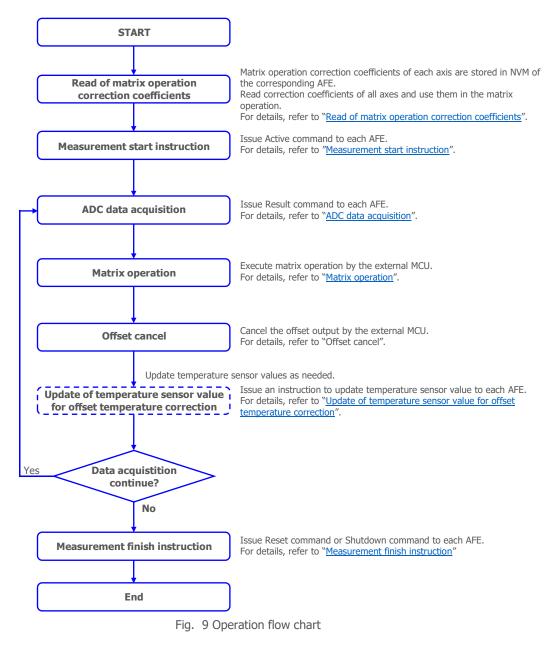
FUNCTION

Operation Description

MMS101 can acquire data following the operation flow shown below.

Correction coefficients used in the matrix operation are stored in the memory (NVM: Non-Volatile Memory) built in each AFE. Reading out the correction coefficients before issuance of measurement start instruction allows the matrix operation after ADC data of each axis is acquired. Offset output may occur even under no-load condition after the upper and lower sensor attachments are installed with screws. Cancel the offset output with an external MCU.

ADC data offset changes depending on ambient temperature. If needed, temperature sensor values used for offset correction arithmetic done in each AFE should be updated at any timing.



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Read of matrix operation correction coefficients

Matrix operation correction coefficients are stored in the memory (NVM: Non-Volatile Memory) built in each AFE. The coefficients in the memory are expanded to the memory area (MAC RAM) used for calculation. MAC RAM map in which the matrix operation correction coefficients are expanded is shown in Table2. The coefficients can be read by executing MAC RAM read command. MAC RAM read command reads data with 4 bytes 32bits width of [31:0], but the matrix operation correction coefficient is 3 bytes 24bits of [27:4]. To execute MAC RAM command, AFEs must be in the Idle state. Therefore, Idle command must be issued and executed in advance. For command code and format, refer to "COMMAND CODE" and "SPI format".

b31	b30	b29	b28	b27	b26	b25	b24	b23	b22	b21	b20	b19	b18	b17	b16	b15	b14	b13	b12	b11	b10	b9	b8	b7	b6	b5	b4	b3	b2	b1	b0
0	0	0	0		Matrix operation correction coefficient [27:4]							0	0	0	0																
	1	1			1	I	I	I	I		1		· ·	I	I	I			-	I			1	1	L	I					

Fig. 10 MAC RAM read data

MAC RAM	Bit			mbols in r			mula(not	e ⁵)
Addr.	DIL		AFE1	AFE2	AFE3	AFE4	AFE5	AFE6
	[31:28]	-						
66h	[27:4]	Matrix operation correction coefficient 1	A1	B1	C1	D1	E1	F1
	[3:0]							
	[31:28]							
67h	[27:4]	Matrix operation correction coefficient 2	A2	B2	C2	D2	E2	F2
	[3:0]							
	[31:28]							
68h	[27:4]	Matrix operation correction coefficient 3	A3	B3	C3	D3	E3	F3
	[3:0]							
69h-6Bh	-	For Manufacturer						
	[31:28]							
6Ch	[27:4]	Matrix operation correction coefficient 4	A4	B4	C4	D4	E4	F4
	[3:0]							
	[31:28]							
6Eh	[27:4]	Matrix operation correction coefficient 5	A5	B5	C5	D5	E5	F5
	[3:0]							
	[31:28]							
6Fh	[27:4]	Matrix operation correction coefficient 6	A6	B6	C6	D6	E6	F6
	[3:0]							

Table 2 MAC RAM map in which the matrix operation correction coefficients

note⁵: For details of matrix operation formula, refer to "Matrix operation".

Measurement start instruction

Each AFE starts AD conversion when receiving Active command. For command code and format, refer to "<u>COMMAND CODE</u>" and "<u>SPI format</u>". Fig. 10 schematically shows an example of AD conversion start instruction issued to AFE1. This instruction must be issued to all AFEs because matrix operation uses ADC data of all axes.

ADC data is subject to offset temperature correction in each AFE. Approximately 7.5 msec is required to complete the first AD conversion because of temperature sensor measurement for offset temperature correction and waiting for filter stabilization. From the second AD conversion, the conversion is repeated at the interval of approximately 0.8 msec because neither the temperature sensor measurement nor waiting for filter stabilization is required.

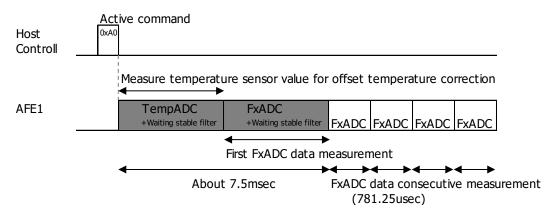
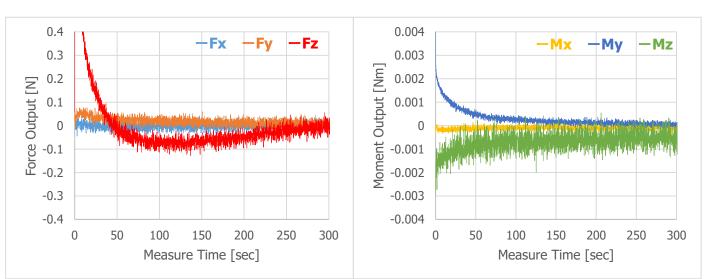


Fig. 11 Schematic of AD conversion start instruction



Immediately after AD converter starts, the built-in AFE heats up and deforms the structure. This causes the output to drift. Therefore, it is recommended to wait for stabilization about 5min before acquiring data.

Fig. 12 Outputting data immediately after AD conversion starts

The second and subsequent ADC data are subject to offset temperature correction using temperature sensor values acquired during the initial AD conversion. This makes correction error larger with changes in ambient temperature, requiring regular update of the temperature sensor values. For update of temperature sensor values, refer to "Update of temperature sensor value for offset temperature correction".

ADC data acquisition

To acquire ADC data (3 bytes / 24 bits), Result command should be issued to each AFE. For command code and format, refer to "<u>COMMAND CODE</u>" and "<u>SPI format</u>". Fig. 11 schematically shows an example of ADC data acquisition from AFE1. Result command must be issued to all AFEs to acquire ADC data of all axes because matrix operation uses this data.

Each AFE returns the last AD-converted data when receiving Result command. If Result command is issued during the first AD conversion, ADC data will be 000000 h.

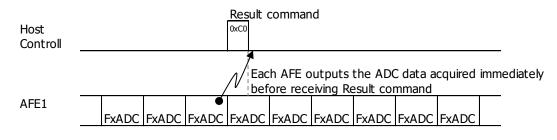
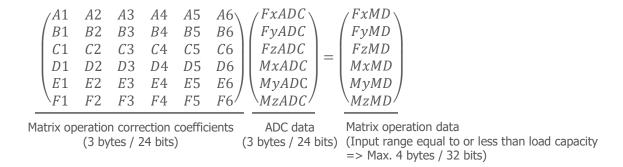


Fig. 13 Schematic of ADC data acquisition

Matrix operation

Please execute the matrix operation below by an external MCU, using matrix operation correction coefficients (3 bytes / 24 bits) and ADC data (3 bytes / 24 bits).

Matrix operation formula (note⁶)



Matrix operation data FxMD to MxMD should be right-shifted by 11 bits to convert the force into 0.001*N and the moment into 0.00001*N·m.

 $\begin{aligned} Fx &= FxMD \div 2^{11} \ [0.001^*N] \\ Fy &= FyMD \div 2^{11} \ [0.001^*N] \\ Fz &= FzMD \div 2^{11} \ [0.001^*N] \\ Mx &= MxMD \div 2^{11} \ [0.00001^*N \cdot m] \\ My &= MyMD \div 2^{11} \ [0.00001^*N \cdot m] \\ Mz &= MzMD \div 2^{11} \ [0.00001^*N \cdot m] \end{aligned}$

note⁶: Determinant expansion

$$\begin{split} FxMD &= A1 \times FxADC + A2 \times FyADC + A3 \times FzADC + A4 \times MxADC + A5 \times MyADC + A6 \times MzADC \\ FyMD &= B1 \times FxADC + B2 \times FyADC + B3 \times FzADC + B4 \times MxADC + B5 \times MyADC + B6 \times MzADC \\ FzMD &= C1 \times FxADC + C2 \times FyADC + C3 \times FzADC + C4 \times MxADC + C5 \times MyADC + C6 \times MzADC \\ MxMD &= D1 \times FxADC + D2 \times FyADC + D3 \times FzADC + D4 \times MxADC + D5 \times MyADC + D6 \times MzADC \\ MyMD &= E1 \times FxADC + E2 \times FyADC + E3 \times FzADC + E4 \times MxADC + E5 \times MyADC + E6 \times MzADC \\ MzMD &= F1 \times FxADC + F2 \times FyADC + F3 \times FzADC + F4 \times MxADC + F5 \times MyADC + F6 \times MzADC \\ \end{split}$$

Matrix operation correction coefficient (A1 to F6) ٠ Matrix operation correction coefficient is 3 bytes (24 bits). A negative number is expressed by 2's complement.

HEX.	DEC.
800000 h	-8388608
FFFFFF h	-1
000000 h	0
000001 h	1
000800 h	2048
7FFFFF h	8388607

Table 3 Example of matrix operation correction coefficient

· ADC data (FxADC to MzADC)

ADC data is 3 bytes (24 bits). A negative number is expressed by 2's complement.

Table 4 Example 0	of ADC data output							
HEX.	DEC.							
800000 h	-8388608							
FF63C0 h	-40000							
FFFFFF h	-1							
000000 h	0							
000001 h	1							
009C40 h	40000							
7FFFFF h	8388607							

Table 4	Example	of	ADC	data	output

• Matrix operation data (FxMD to MzMD)

According to calculations, the range of the matrix operation data is 6 bytes (48 bits). For the data measured at the load capacity or less, the range is 4 bytes (32 bits) at the maximum. The matrix operation data uses negative numbers expressed by 2's complement.

Matrix operation	Matrix ope	Force	
data		hift by 11 bits	[N]
HEX.	HEX.	DEC.	
E7960000 h			
S	FFFCF2C0 h	-200000	-200.000
E79607FF h			
FB1E0000 h			
S	FFFF63C0 h	-40000	-40.000
FB1E07FF h			
FFFFF800 h			
S	FFFFFFF h	-1	-0.001
FFFFFFF h			
00000000 h			
Z	0000000 h	0	0.000
000007FF h			
00000800 h			
Z	00000001 h	1	0.001
00000FFF h			
04E20000 h			
ζ	00009C40 h	40000	40.000
04E207FF h			
186A07FF h			
S	00030D40 h	200000	200.000
186A0000 h			

Table 5 Example of matrix operation data – force output

Tuble 0	Table 6 Example of matrix operation data - moment output							
Matrix operation data	Matrix ope After right-sh	Moment						
HEX.	HEX.	DEC.	[N•m]					
EA070000 h	IILA.	DLC.						
2	FFFD40E0 h	-180000	-1.80000					
		-100000	-1.00000					
EA0707FF h								
FB1E0000 h		40000	0.40000					
2	FFFF63C0 h	-40000	-0.40000					
FB1E07FF h								
FFFFF800 h								
S	FFFFFFF h	-1	-0.00001					
FFFFFFF h								
00000000 h								
S	00000000 h	0	0.00000					
000007FF h								
00000800 h								
ζ	00000001 h	1	0.00001					
00000FFF h								
04E20000 h								
S	00009C40 h	40000	0.40000					
04E207FF h								
15F907FF h								
S	0002BF20 h	180000	1.80000					
15F90000 h								

 Table 6
 Example of matrix operation data - moment output

Offset cancel

Offset output may occur even under no-load condition after the upper and lower sensor attachments are installed with screws. Also, Immediately after AD converter starts, the built-in AFE generates heat and drifts. Therefore, the data acquired in the no-load condition after drift stabilization should be the offset data Fxoff~ Mzoff and the process of offset cancel by the external MCU should be performed.

 $\begin{array}{l} Fx' = Fx - Fxoff \ [0.001*N] \\ Fy' = Fy - Fyoff \ [0.001*N] \\ Fz' = Fz - Fzoff \ [0.001*N] \\ Mx' = Mx - Mxoff \ [0.00001*N \cdot m] \\ My' = My - Myoff \ [0.00001*N \cdot m] \\ Mz' = Mz - Mzoff \ [0.00001*N \cdot m] \end{array}$

Measurement finish instruction

Each AFE completes AD conversion and ends measurement when receiving Reset command or Shutdown command. For command code and format, refer to "<u>COMMAND CODE</u>" and "<u>SPI format</u>". Fig. 12 schematically shows an example of measurement finish instruction issued to AFE1. Measurement finish instruction must be issued to all AFEs.

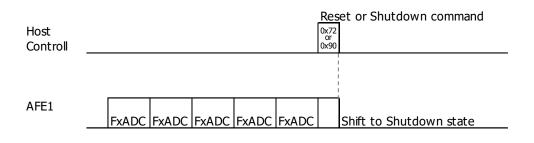


Fig. 14 Schematic of measurement finish instruction

Update of temperature sensor value for offset temperature correction

After AD conversion starts, the second and subsequent ADC data are subject to offset temperature correction using temperature sensor values acquired during the first AD conversion. This makes correction error larger with changes in ambient temperature, requiring regular update of the temperature sensor values. However, note that this feature is not effective enough if the temperature distribution in the sensor is uneven when the environmental temperature is changing.

Write Register command is used to update temperature sensor values for offset temperature correction. Fig. 13 schematically shows an example of the update of such data in AFE1. By executing Write Register command and writing data 0x01 to register address 0x3F at any timing, on-going AD conversion is completed, AD conversion of the temperature sensor is done again, and the data is updated. For command code and format, refer to "<u>COMMAND CODE</u>" and "<u>SPI format</u>".

The last ADC data can also be acquired during update of the temperature sensor values.

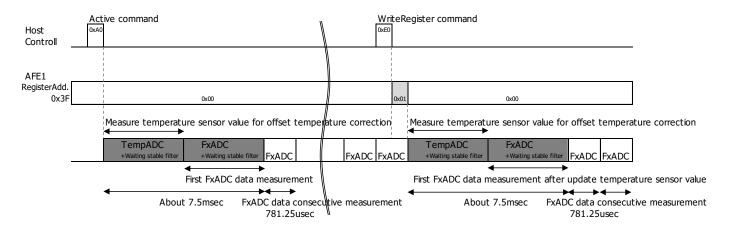
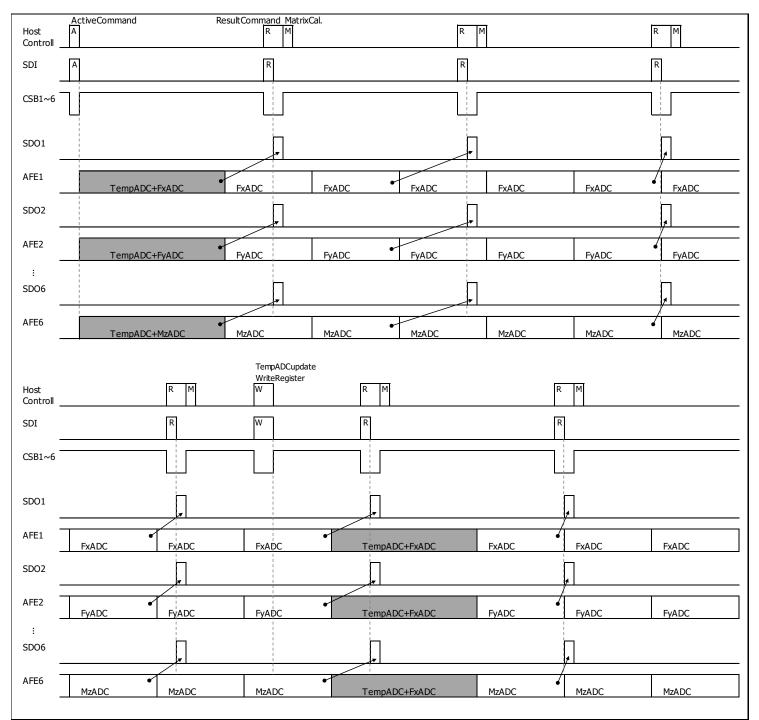


Fig. 15 Schematic of update of temperature sensor values for offset temperature correction

Measurement timing chart



*AD conversion cycle depends on AFE because internal clock is different from each AFE. Fig. 16 Integrated CSB pin - Measurement timing chart

Host Controll		MatrixCal. Result M Command	Result M Command	Result M Command
SDI	A A A 1 2 6	R R R 1 2 6	R R R 1 2 6	R R R 1 26
SDO1~6				
CSB1	1		$\leq / $	
AFE1	TempADC+FxADC FxADC FxADC	FxADC FxADC	FxADC FxA	
CSB2		─//		
AFE2	TempADC+FyADC FyAD	DC FyADC FyAI	DC FyADC F	/ADC FyADC
:				
CSB6		<u>′</u>] [/ [
AFE6	• TempADC+MzADC	MzADC MzADC	MzADC MzADC	MzADC MzADC
	Temproternizite			
Host Controll		mpADCupdate Result M riteRegister Command	Result Command	М
SDI	R R R W 1 2 6 1	W W R R R 2 6 1 2 6	R R 1 2 ····	R 6
SD01~6				
				†
CSB1				
CSB1 AFE1	FxADC FxADC Fx	ADC		FxADC
	FxADC FxADC Fx			FxADC
AFE1			FxADC FxADC	
AFE1 CSB2		ADC /TempADC+FxADC	FxADC	
AFE1 CSB2 AFE2 :		ADC /TempADC+FxADC	FxADC	
AFE1 CSB2 AFE2		ADC /TempADC+FxADC	FxADC	
AFE1 CSB2 AFE2 : CSB6		ADC /TempADC+FxADC	FxADC	
AFE1 CSB2 AFE2 :		ADC /TempADC+FxADC	PXADC FXADC	

*AD conversion cycle depends on AFE because internal clock is different from each AFE. Fig. 17 Integrated SDO pin - Measurement timing chart

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	-			Table	7 Com	mand c	ode list			
	Comm	and Co	de							
Command Name					Format					
	HEX.	C7	C6	C5	C4	C3	C2	C1	C0	
	0x72	0	1	1	1	0	0	1	0	SPI Write format
Reset				Shutdo comma			ecome	s busy	for the	maximum 1.8msec.
	0x90	1	0	0	1	0	0	0	0	SPI Write format
Shutdown			lown st ly with	ate. comma	and cod	le.				
	0x94	1	0	0	1	0	1	0	0	SPI Write format
Idle		Start up the internal circuit and put it in the Idle state. Operation only with command code.								
	0xA0	1	0	1	0	0	0	0	0	SPI Write format
Active	Start AD conversion. Operation only with command code.									
	0xC0	1	1	0	0	0	0	0	0	SPI Write/Read format
Read ADC Result	A nega For ou while r Howey	ADC data (3 bytes /24 bits) is output MSB first. A negative number is expressed by 2's complement. For output range, positive output is 000000 h to 7FFFFF h (0 to +8388607 in decimal number), while negative output is FFFFFF h to 800000 h (-1 to -8388608 in decimal number). However, the measurement data acquired during the usage beyond the recommended operating conditions cannot be guaranteed.								
	0xC2	1	1	0	0	0	0	1	0	SPIWrite/Read format
Read Temperature ADC Result	ADC data (3 bytes /24 bits) is output MSB first.A negative number is expressed by 2's complement.For output range, positive output is 000000 h to 7FFFFF h (0 to +8388607 in decimal number), while negative output is FFFFFF h to 800000 h (-1 to -8388608 in decimal number).However, the measurement data acquired during the usage beyond the recommended operating conditions cannot be guaranteed.Temperature value[$^{\circ}$ C] = DEC./2^16 Output exampleBIN.HEX.DEC.Temperature									

	000001010000000000000000 b				0500	00 h	3276	580	5.000°C			
		00011001000000000000000 b					1900	00 h	1638400		25.000°C	
		0010)11010	000000	000000	0000 b	2D00	00 h	29491	20	45.000°C	
		0xE0	1	1	1	0	0	0	0	0	SPI Write for	ormat
Write Register	It is used for writing date to resister. After sending command code, send in the order of memory address of 8 bits and write data of 8 bits. After transmitting command code,									its and write data of 8		
Read MAC RAM		0xD4	1	1	0	1	0	1	0	0	SPI Write/Re	ad format (Busy)
Redu MAC RAM		It is used for reading matrix operation correction coefficients of MAC RAM.										

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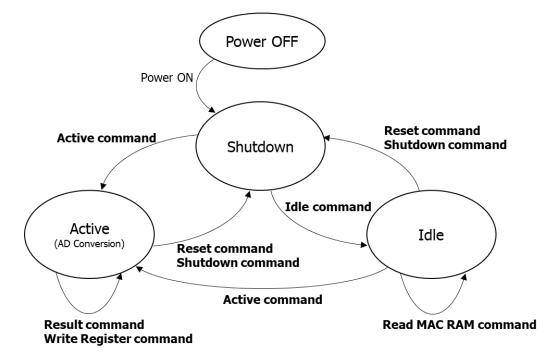


Fig. 18 State transition diagram

l able 8 State transition table						
State Command	Shutdown	Active	Idle			
Reset	Power on Reset & Initial Boot =>Shutdown state	Power on Reset & Initial Boot =>Shutdown state	Power on Reset & Initial Boot =>Shutdown state			
Shutdown	=>Keep state	=>Shutdown state	=>Shutdown state			
Active	Reset & Boot Load =>Active state (AD conversion)	Ignore(note ⁷) =>Keep state	=>Active state (AD conversion)			
Result	Ignore(note ⁷) =>Keep state	Output result =>Keep state	Do not issue(note ⁸) =>Keep state			
Idle	Reset & Boot Load =>Idle state	Do not issue(note ⁹) =>Idle state	=>Keep state			
Write Register	Ignore(note ⁷) =>Keep state	Temperature ADC update =>Keep state	Do not issue(note ¹⁰) =>Keep state			
Read MAC RAM	Ignore(note ⁷) =>Keep state	Do not issue(note ⁹) =>Keep state	Output Matrix coeff. =>Keep state			

Table 8State transition table

note⁷: NACK is returned to the command.

note⁸: The correct result is not output. Additionally, ACK is returned to the command.

note⁹: Although command is acceptable, it goes unintended behavior since sequence is running.

note¹⁰: Although command is acceptable, it goes unintended behavior during sequence execution.

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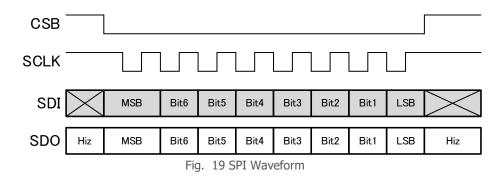
SERIAL INTERFACE

It supports SPI as an interface for serial communication.

Table 9 Baud rate								
Items	Symbol	Condition	Min.	Тур.	Max.	Unit.		
SPI communication speed	BR _{SPI1}	$\begin{array}{l} \text{VDDIO} \geqq 2.0\text{V} \\ \text{Cb} \leqq 100\text{pF} \end{array}$	-	-	5.0			
	BR SPI2	VDDIO < 2.0V Cb < 100pF	-	-	1.0	Mbps		
	BR _{SPI3}	$\begin{array}{l} \text{VDDIO} \geqq 2.0\text{V}\\ \text{Cb} \leqq 400\text{pF} \end{array}$	-	-	2.5	Pupps		
	BR _{SPI4}	VDDIO < 2.0V Cb < 400pF	-	-	0.5			

SPI format

The basic format of SPI is shown below. The relationship between clock (SCLK) and data (SDI/SDO) is Mode3.Data send/receive is started when CSB becomes low level from the status when SCLK is high level. Data is updated on falling edges of the SCLK, and sampled on rising edges of the SCLK. Data send/receive is ended when CSB becomes high level from the status when SCLK is high level.



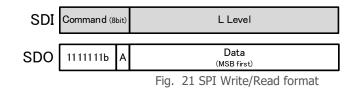
SPI Write format

Please send command code of 8 bits. When the command is received, it turns over ACK to 8 bits. If there is data, please continue sending.



SPI Write/Read format

Please send command code of 8 bits. When the command is received, it turns over ACK to 8 bits and it outputs the data MSB first.



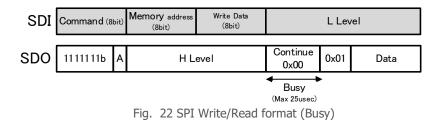
SPI Write/Read format (Busy)

Please send command code of 8 bits. When their commands are received, it turns over ACK to 8 bits. Then, please send memory address of 8 bits. After receiving the memory address, the internal area becomes busy for 25usec at the maximum in order to prepare for data transmission. During this time, it returns 0x00 which indicates busy state. When data preparation is completed, it outputs 0x01, followed by data of 8 bits.

How to discern busy state:

Please continue clock input in the same communication status after transmitting the write data. Then, it returns 0x00 which indicates busy status. It returns 0x01 when writing is completed.

* 0x00 to indicate busy may sometimes be output or not depending on the clock frequency.



SPI ACK

When command code which is send in each SPI format is received, it outputs L level to 8 bits as ACK. If command code is not accepted or command code is not valid, it outputs H level to 8 bits as NACK.

SPI AC Characteristics

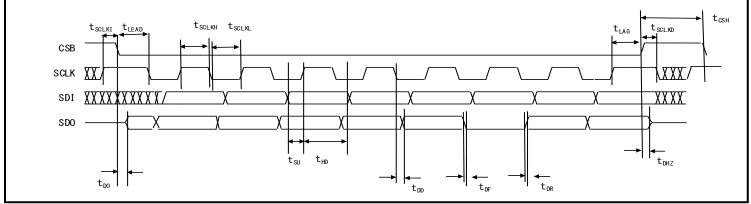


Fig. 23 SPI AC timing chart

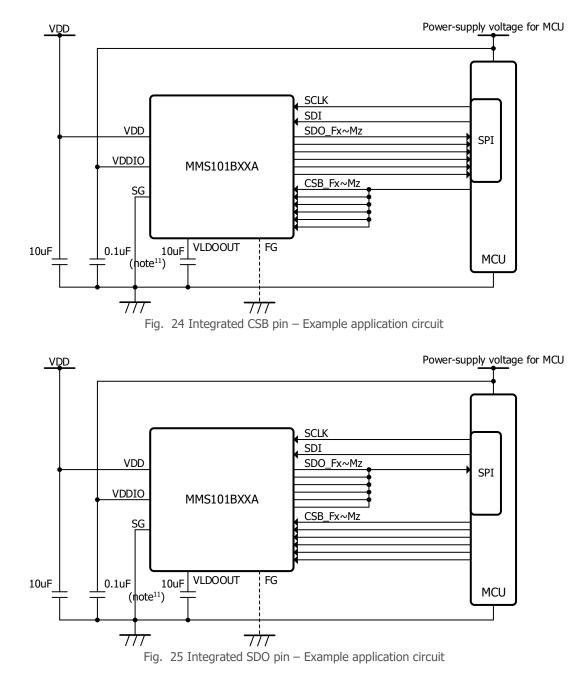
Table 10	SPI AC Characteri	stics	
----------	-------------------	-------	--

Items	Symbol	VDDI	0<2V	VDDI	Unit.	
items	Symbol	min.	max.	min.	max.	Unit.
SCLK frequency(Duty 50±10%)	f _{SCLK}	-	1	-	5	MHz
SCLK High period (90%~90%)	tsclkh	400	-	80	-	ns
SCLK Low period(10%~10%)	tsclkl	400	-	80	-	ns
SCLK wait time	tsclki	500	-	100	-	ns
SCLK Delay time	tsclkd	0	-	0	-	ns
CSB High period(90%~90%)	tcsн	1000	-	200	-	ns
Time from CSB falling to SCLK falling	tlead	0	-	0	-	ns
Time from SCLK rising to CSB rising	tlag	500	-	100	-	ns
SDI setup time	tsu	100	-	10	-	ns
SDI hold time	t _{HD}	10	-	10	-	ns
SDO rise time(Load 100pF) (10%~90%)	t _{DR}	-	50	-	50	ns
SDO fall time(Load 100pF) (10%~90%)	t _{DF}	-	50	-	50	ns
SDO output delay time(Load 100pF)	t _{DD}	-	120	-	60	ns
SDO output delay time from CSB falling (Load 100pF)	t _{DO}	-	120	-	60	ns
Time from CSB rising to SDO output HiZ (Load 100pF)	tdhz	-	170	-	170	ns

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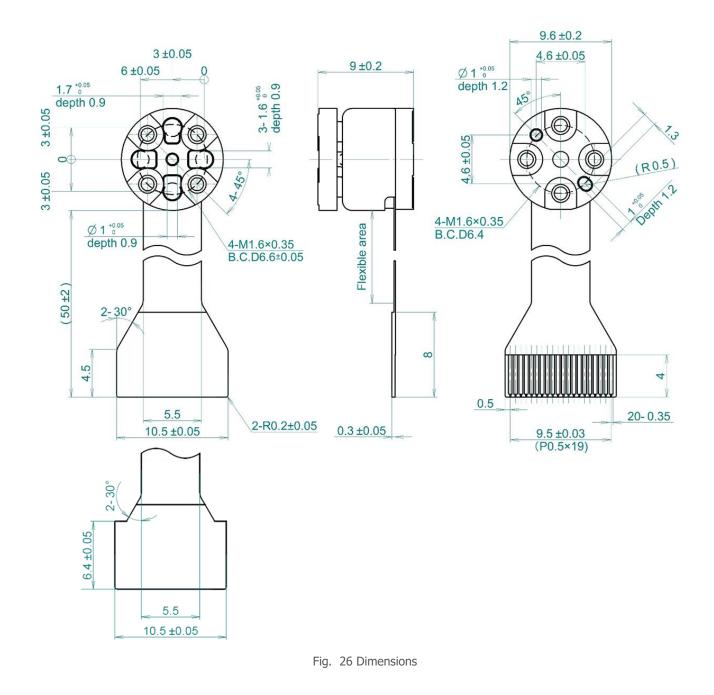
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TYPICAL APPLICATION CIRCUIT



note¹¹: It is recommended to be placed as close as possible for noise reduction.

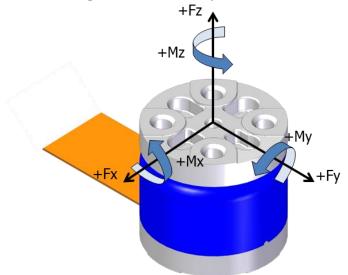
DIMENSIONS

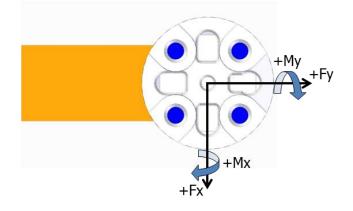


- Recommended FPC connector
- FH52K-20S-0.5SH (HIROSE ELECTRIC CO.,LTD)
- FH28D-20S-0.5SH (HIROSE ELECTRIC CO.,LTD)
- 046288020600846+ (KYOCERA Corporation)

Sensor coordination systems

*The origin is the sensor top surface center.





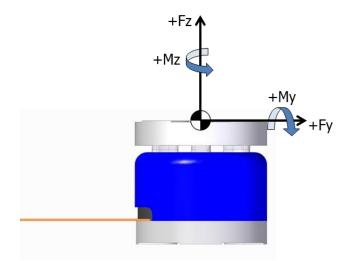


Fig. 27 Sensor coordination systems

Sensor attachment

This product is intended to be used with the sensor attachment mounted on the top and bottom of the product by screws. If the sensor attachment is used without mounting the screws, the input force is not sufficiently transmitted to the product and the accuracy is not satisfied, or the output may drift in response to changes in the environmental temperature.

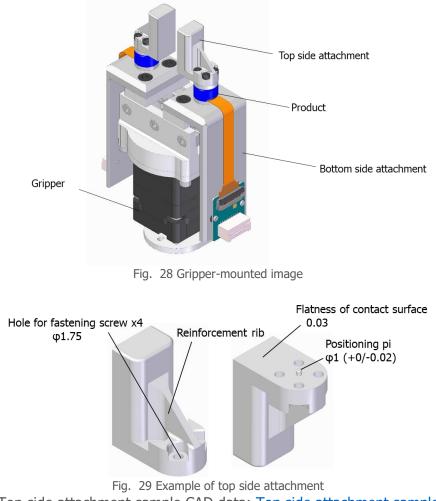
Please design and prepare the sensor attachment by yourself according to your purpose and application.

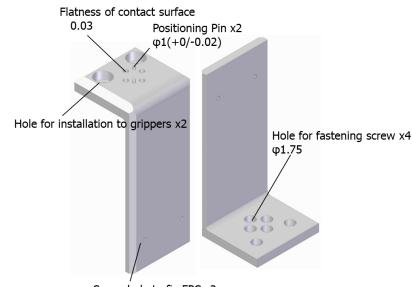
Points in designing sensor attachments:

- In order to minimize the deformation of the sensor when applying a load and to avoid affecting the sensor output, use a highly rigid material such as SUS that is not easily deformed.
- In an environment where the ambient temperature is likely to change, the shape should be such that the heat capacity can be secured as large as possible.

Example of sensor attachment

Fig.29, 30 and 31 show examples of shapes of top and bottom side sensor attachments supposed to be mounted on a gripper and examples of their mounting.





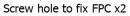


Fig. 30 Example of bottom side attachment Bottom side attachment sample CAD data: <u>Bottom side attachment sample.zip</u>

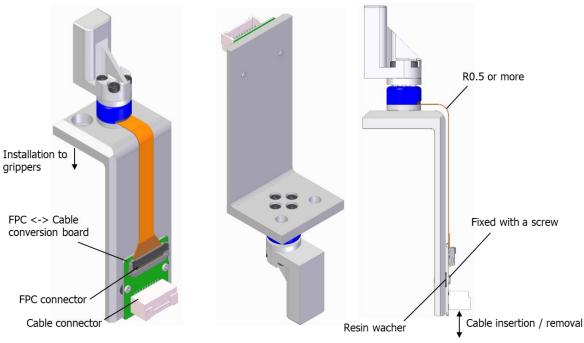


Fig. 31 Example of attachment installation

It is recommended to fix the board connected to FPC to the attachment with a screw so that the FPC is not bent repeatedly. Additionally, cables should be inserted and removed with the FPC fixed to the attachment with a screw to minimize load to the FPC.

Fig. 29, 30 and 31 show examples. The attachment should be designed depending on the intended use.

This product is a precision measuring instrument. Therefore, it needs to be installed following the appropriate procedure to avoid overload to it. Failure to observe the recommendations included in this manual may cause damage to the sensor.

Installation screw

Four M1.6 screws should be used for installation on both top and bottom surfaces. **Length of the screws inserted in the installation holes of both surfaces should be 1.7 mm or shorter.** The tapped holes are 1.8 mm (min. 1.7 mm) through holes. If the screw length exceeds 1.7mm, FPC or IC located near the through hole inside the product may be damaged.

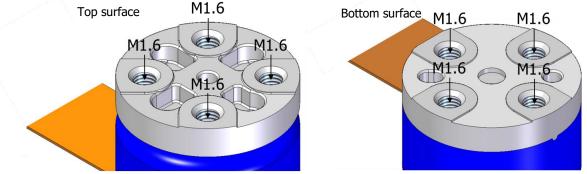
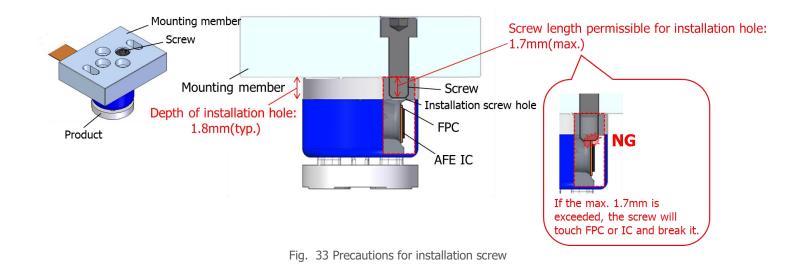
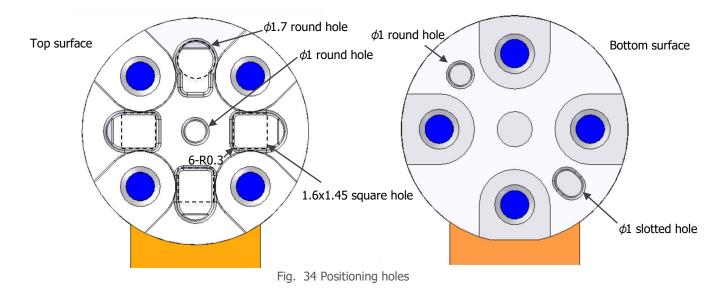


Fig. 32 Installation screw holeIn



Positioning hole

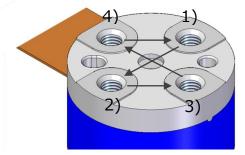
For the top surface, a φ 1 round hole in the middle, a φ 1.7 round hole, or 1.6 x 1.45 mm square holes can be used for positioning. For the bottom surface, a φ 1 round hole and a φ 1 slotted hole can be used for positioning. For details, refer to "<u>DIMENSIONS</u>".



Recommended tightening method of sensor installation screw

The recommended tightening torque is 0.15N·m for M1.6 screws used to install this sensor. DO NOT fasten one screw tightly at first step, or the sensor may detect incorrect force and moment. In the worst case, the sensor could be damaged.

Screws must be fastened in the diagonal order as shown below. **First, they should be lightly fastened**, and then, fastened in more than 2 steps with the recommended tightening torque.



Ex. 1st round 1)0.05N·m -> 2)0.05N·m -> 3)0.05N·m -> 4)0.05N·m 2^{nd} round 1)0.15N·m -> 2)0.15N·m -> 3)0.15N·m -> 4)0.15N·m

Fig. 35 Example of screw tightening order

Sensor contact surface

Flatness of the sensor side contact surface is 0.03mm, and the installation side contact surface should be designed at the same flatness. Level difference resulting from poor flatness could cause the force and the moment to be detected incorrectly. In the worst case, the sensor could be damaged. The installation side contact surface needs to be rigid enough against loads.

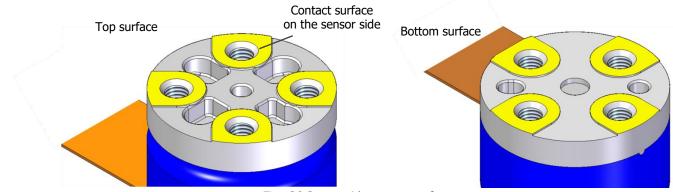


Fig. 36 Sensor side contact surface

PRECAUTIONS FOR SENSOR HANDLE

This product is a precision measuring instrument. Therefore, it needs to be handled following the appropriate procedure to avoid overload to it. Failure to observe the recommendations included in this manual may cause damage to the sensor.

Handling of sensor FPC

The FPC must NOT be strongly pulled in a lateral or the upper direction while the sensor body is fixed with screws. Otherwise, load is applied to the base of the FPC, and the wiring on the FPC might be snapped. Also, do not mount the product on moving parts that are bent repeatedly.

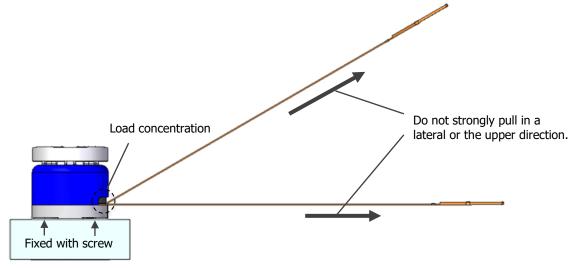
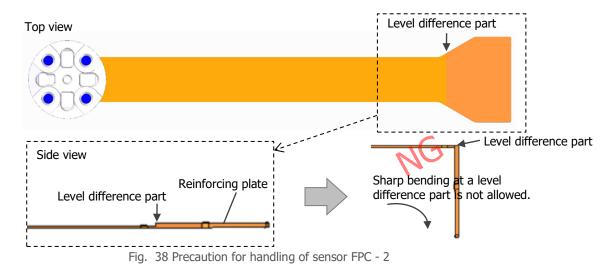


Fig. 37 Precaution for handling of sensor FPC - 1

In the FPC termination part, a level difference exists between the FPC and the reinforcing plate. Bending the FPC at this level difference part could cut the wiring on the FPC.

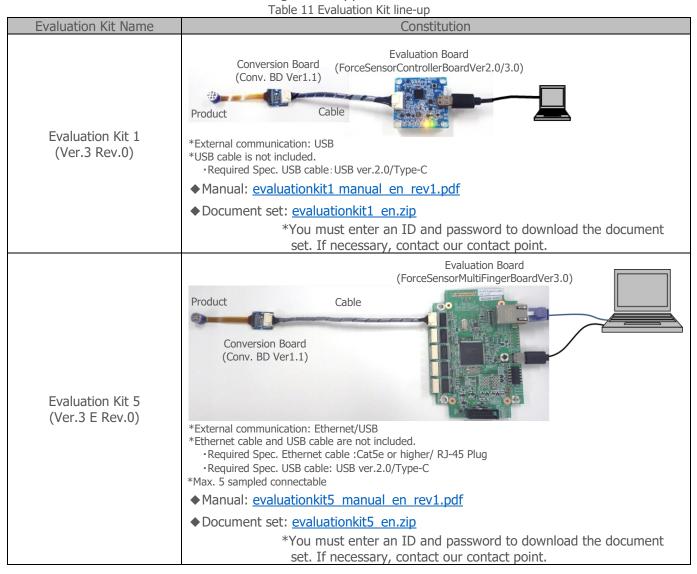


OPTION

As options, evaluation kit and conversion board are available. Please order if necessary. However, the options are guaranteed only for checking the operation at the time of shipment, and will only be provided for sample support. Please note.

Evaluation Kit

Using evaluation kit with PC applications allows logging data to be acquired. In addition to product to which conversion board for evaluation kit are connected, they consist of cables and evaluation board. There are two kinds of evaluation kits. Select them according to the application.



Cable

<u> </u>		Table 12 Cable line-up
Cable Type	Cable length	Cable appearance
Lead cable	15, 30cm	 Cable line: UL3302 AWG28 (FURUKAWA ELECTRIC CO.,LTD.) UL3302 AWG28 Spiral tube Housing: NSHDR-20V-Z (J.S.T.MFG. CO., LTD)
Robot cable	30, 60, 150cm	 Cable line: RMDH II -SB (21913) (DYDEN CORPORATION) Cable line: RMDH II -SB (21913) (DYDEN CORPORATION) Braided Shield Housing: NSHDR-20V-Z (J.S.T.MFG.CO., LTD.) Shade terminal (Y type): 0.3Y-3 (NICHIFU CO., LTD.)

Evaluation Board

		Ta		on Board line-up
Board Name	External Communication	Power Supply	No. of connectable sensors	Board appearance
ForceSensor ControllerBoard Ver2.0/3.0 *No functional differences between Ver2.0 and Ver3.0	USB	USB	Max. 1 pc	40mm 40mm 40mm 40mm 40mm 40mm 6.1mm 6.1mm Conversion Board side connector : SM20B-NSHDZS (J.S.T.MFG. CO., LTD) External communication side connector : CAM-L05-024-050-ACGAA (MITSUMI ELECTRIC CO., LTD)
ForceSensor MultiFingerBoard Ver3.0	Ethernet/USB	USB	Max. 5 pcs *Only for Ethernet communication	80mm 115mm 115mm Conversion Board side connector SM20B-NSHDZS (J.S.T.MFG. CO., LTD.) External communication side connector : J3011G21DNLT (Pulse Electronics CO., LTD.) DC jack : M04-730A0 (MARUSHIN ELECTRIC MFG. CO., LTD.)

Conversion Board

Conversion Board is intended to connect a cable to this product. Connect the product terminal to the FPC connector and convert it to a cable connector with the number of pins according to the application.

Board Name	Terminal conversion table				Board appearance
Conv. BD Ver1.1 (For Evaluation Kit)	Output O VDD VD VDDIO V VLDOOUT VLI SG SG FG SCLK SDI CSB_Fx	20p Output VDD 0 LDOOUT 0 SG 0 FG 0 N.C. 0 SCLK 0 SDI 0 CSB_Fx 0 CSB_Fy 0	in MMS101 Output CSB_Fz CSB_Mx CSB_My CSB_Mz SDO_Fx SDO_Fy SDO_Fz SDO_Mx SDO_My SDO_Mz	Conv.BD Output CSB_Fz CSB_Mx CSB_My CSB_Mz SDO_Fx SDO_Fy SDO_Fz SDO_Fz SDO_Mx SDO_Mz	20mm ↓ 17mm 0.5mm ↓ 6.1mm • Sensor side connector : FH52K-20S-0.5SH (HIROSE ELECTRIC CO.,LTD) • Controll/Evaluation board side connector : SM20B-NSHDZS (J.S.T.MFG. CO., LTD.)

Table 14 Conversion board line-up

NOTES

NOTES

[Safety Precautions]

- Though Mitsumi Electric Co., Ltd. (hereinafter referred to as "Mitsumi") works continually to improve our product's quality and reliability, semiconductor products may generally malfunction or fail. Customers are responsible for complying with safety standards and for providing adequate designs and safeguards for their hardware, software and systems which minimize risk and avoid situations in which a malfunction or failure of this product could cause loss of human life, bodily injury, or damage to property, including data loss or corruption. Before customers use this product, create designs including this product, or incorporate this product into their own applications, customers must also refer to and comply with (a) the latest versions or all of our relevant information, including without limitation, product specifications, data sheets and application notes for this product and (b) the user's manual, handling instructions or all relevant information for any products which is to be used, or combined with this products. Customers are solely responsible for all aspects of their own product design or applications, including but not limited to (a) determining the appropriateness of the use of this product in such design or applications; (b) evaluating and determining the applicability of any information contained in this document, or in charts, diagrams, programs, algorithms, sample application circuits, or any other referenced documents; and (c) validating all operating parameters for such designs and applications. Mitsumi assumes no liability for customers' product design or applications.
- This product is intended for applying to computers, OA units, communication units, instrumentation units, machine tools, industrial robots, AV units, household electrical appliances, and other general electronic units.
- If you have any intentions to apply this product to the units related to the control and safety of transportation units (vehicles, trains, etc.), traffic signaling units, disaster-preventive & burglar-proof units, or the like, contact our sales representatives in advance.
- Don't apply this product to any aeronautical & space systems, submarine repeaters, nuclear power controllers, medical units involving the human life, Military-related equipment, or the like.
- Before using this product, even when it is not used for the usage written above, notify and present us beforehand if special care and attention are needed for its application, intended purpose, environment of usage, risk, and the design or inspection specification corresponding to them.
- If any damage to our customer is objectively identified to be caused by the defect of this product, Mitsumi is responsible for it. In this case, Mitsumi is liable for the cost limited to the delivery price of this product.

[Application considerations during actual circuit design]

- The outline of parameters described herein has been chosen as an explanation of the standard parameters and performance of the product. When you actually plan to use the product, please ensure that the outside conditions are reflected in the actual circuit and assembling designs.
- Before using this product, please evaluate and confirm the actual application with this product mounted and embedded.
- To investigate the influence by applied transient load or external noise, it is necessary to evaluate and confirm them with mounting this product to the actual application.
- Any usage above the maximum rating may destroy this product or shorten the lifetime. Be sure to use this product under the maximum rating.
- If you continue to use this product highly-loaded (applying high temperature, large current or high voltage; or variation of temperature) even under the absolute maximum rating and even in the operating range, the reliability of this product may decrease significantly. Please design appropriate reliability in consideration of power dissipation and voltage corresponding to the temperature and designed lifetime after confirming our individual reliability documents (such as reliability test report or estimated failure rate). It is recommended that, before using this product, you appropriately derate the maximum power dissipation (typically, 80% or less of the maximum value) considering parameters including ambient temperature, input voltage, and output current.

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- If a use of this product causes a dispute related to the industrial property rights of a third party, Mitsumi has no liability for any disputes except those which arise directly from the manufacturing and manufacturing method of our products.

[Precautions for Product Liability Act]

• No responsibility is assumed by us for any consequence resulting from any wrong or improper use or operation, etc. of this product.

[Others]

• Any part of the contents contained herein must not be reprinted or reproduced without our prior permission.

In case of any question arises out of the description in this specification, it shall be settled by the consultation between both parties promptly.

ATTENTION

This product is designed and manufactured with the intention of normal use in general electronics. No special circumstance as described below is considered for the use of it when it is designed. With this reason, any use and storage under the circumstances below may affect the performance of this product. Prior confirmation of performance and reliability is requested to customers.

Environment with strong static electricity or electromagnetic wave Environment with high temperature or high humidity where dew condensation may occur

This product is not designed to withstand radioactivity, and must avoid using in a radioactive environment.

ADDITIONAL NOTES

- In the event of any defect in this product, you may send us the product. Then, we will perform an
 appropriate analysis and consult with you about appropriate remedy for the problem proposed by our sole
 discretion.
- Handle with care to prevent foreign matter from entering the screw holes and product gaps.
- When installing this product, design it so that the length of the screw inserted into the product mounting hole is 1.7mm or less. The product mounting hole is a through hole. If it exceeds 1.7mm, the internal parts will be damaged or malfunction. Also, we recommend that the tightening torque of the screws during mounting be 0.15N·m.
- Do not bend the FPC at a sharp angle or pull it hard so that the load is concentrated. Otherwise, the wiring on the FPC may be broken, resulting in operation failure.

MITSUMI ELECTRIC CO., LTD.

Strategy Engineering Department Semiconductor Business Division

Tel: +81-46-230-3470 / http://www.mitsumi.co.jp

Notes:

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